

Description

The HN6974 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

V_{DS} = 60V I_D =40 A

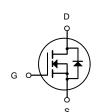
 $R_{DS(ON)}$ < 15m Ω @ V_{GS} =10V

Application

Battery protection

Load switch

Uninterruptible power supply



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
HN6974	DFN3X3-8L	HN6974 XXXX	5000

Absolute Maximum Ratings (Tc=25℃unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	60	V
VGS	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	40	А
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	20	А
IDM	Pulsed Drain Current ²	150	А
EAS	Single Pulse Avalanche Energy ³	36	mJ
P _D @T _C =25°C	Total Power Dissipation⁴	30	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R _θ JA	Thermal Resistance Junction-ambient ¹	62	°C/W
R₀JC	Thermal Resistance Junction-Case ¹	2.5	°C/W



Electrical Characteristics (T_J=25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units		
Off Charac	Off Characteristic							
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	60	-	_	V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V,	-	-	1.0	μA		
I _{GSS}	Gate to Body Leakage Current	V _{DS} =0V, V _{GS} = ±20V	-	-	±100	nA		
On Charac	cteristics							
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.0	1.6	2.5	V		
Б	Static Drain-Source on-Resistance	V _{GS} =10V, I _D =20A	-	12	15			
$R_{DS(on)}$		V _{GS} =4.5V, I _D =10A	-	15	20	mΩ		
Dynamic (Characteristics		1	1				
C _{iss}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1.0MHz	-	930	_	pF		
Coss	Output Capacitance		-	230	-	pF		
C _{rss}	Reverse Transfer Capacitance		-	8	-	pF		
Qg	Total Gate Charge	\/ -20\/ I -20A	-	22	-	nC		
Q _{gs}	Gate-Source Charge	V _{DS} =30V, I _D =20A,	-	4.5	-	nC		
Q _{gd}	Gate-Drain("Miller") Charge	V _{GS} =10V	-	3.5	-	nC		
Switching	Characteristics							
t _{d(on)}	Turn-on Delay Time		-	4.5	_	ns		
t _r	Turn-on Rise Time	V_{DD} =30V, I_{D} =20A, R_{G} =1.6 Ω , V_{GS} =10V	-	2.7	-	ns		
t _{d(off)}	Turn-off Delay Time		-	13.8	-	ns		
t _f	Turn-off Fall Time		-	2.7	-	ns		
Drain-Sou	rce Diode Characteristics and Maxim	um Ratings	•					
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	40	А		
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	150	Α		
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} =0V, I _S =30A	-	-	1.2	V		
t _{rr}	Body Diode Reverse Recovery Time	T -05°C	-	18	-	ns		
Qrr	Body Diode Reverse Recovery Charge	T _J =25℃, I _F =20A,dI/dt=100A/μs	-	12	-	nC		

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

^{2.} EAS condition: TJ=25 $^{\circ}\text{C}$, VDD=30V, VG=10V, RG=25 Ω , L=0.5mH, IAS=12A

^{3.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



Typical Performance Characteristics

Figure1: Output Characteristics

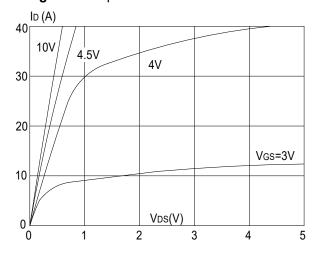


Figure 3:On-resistance vs. Drain Current

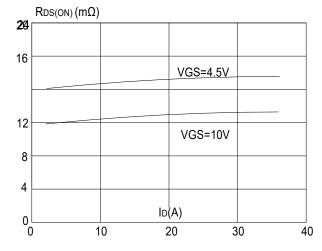


Figure 5: Gate Charge Characteristics

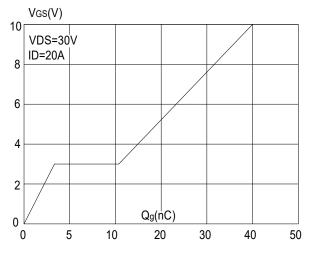


Figure 2: Typical Transfer Characteristics

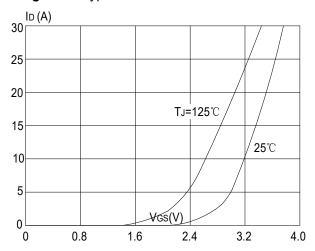


Figure 4: Body Diode Characteristics

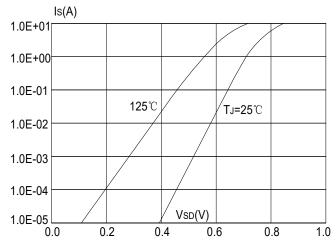


Figure 6: Capacitance Characteristics

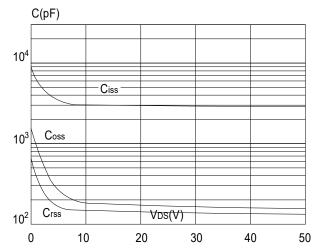




Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

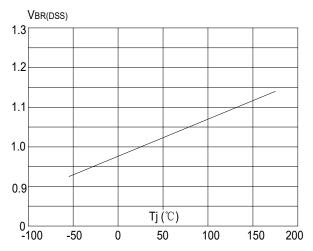


Figure 9: Maximum Safe Operating Area

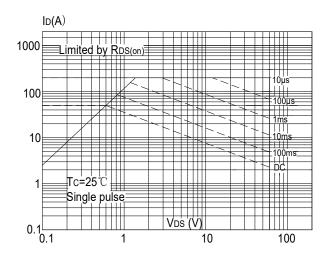


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

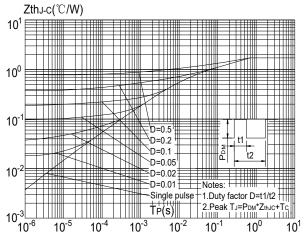


Figure 8: Normalized on Resistance vs. Junction Temperature

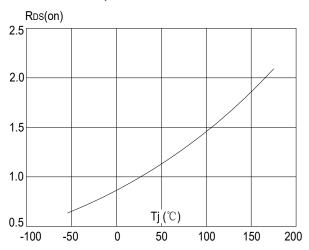
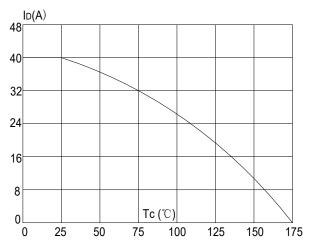
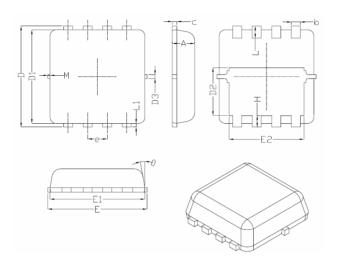


Figure 10: Maximum Continuous Drain Current vs. Case Temperature





DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
e	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
M	*	*	0.15	
θ		10 [°]	12 [°]	



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